# MOSFET – Power, Single N-Channel 40 V, 4.2 mΩ, 83 A

# **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	82	Α
rent R <sub>θJC</sub> (Notes 1 & 3)	Steady	T <sub>C</sub> = 100°C		58	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	$P_{D}$	56	W
(Note 1)		T <sub>C</sub> = 100°C		28	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	19	Α
Current R <sub>0JA</sub> (Notes 1, 2 & 3)	Steady	T <sub>A</sub> = 100°C		14	
Power Dissipation R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.1	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		1.5	
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	446	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	46	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, I <sub>L(pk)</sub> = 8.3 A)			E <sub>AS</sub>	205	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	2.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	48.4	

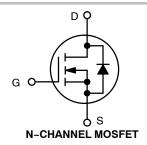
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



# ON Semiconductor®

## www.onsemi.com

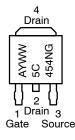
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
40 V	4.2 mΩ @ 10 V	83 A	





DPAK CASE 369C STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location

Y = Year

WW = Work Week

5C454N= Device Code

G = Pb-Free Package

# **ORDERING INFORMATION**

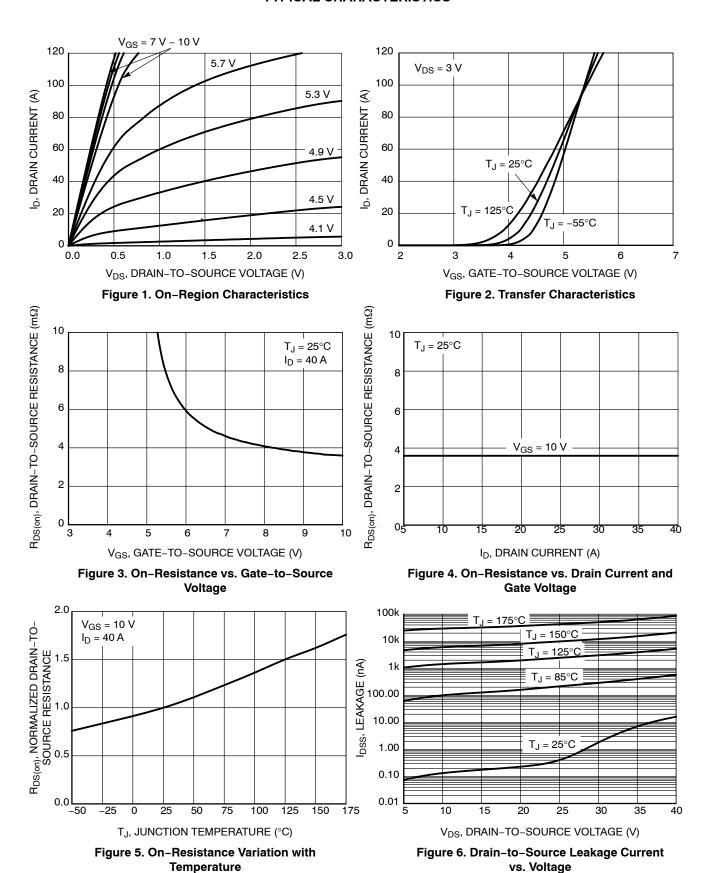
See detailed ordering and shipping information on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Temperature Coefficient  Zero Gate Voltage Drain Current  Gate-to-Source Leakage Current  ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage	V <sub>(BR)</sub> DSS V <sub>(BR)</sub> DSS/T <sub>J</sub> I <sub>DSS</sub> I <sub>GSS</sub> VGS(TH)	$V_{GS} = 0 \text{ V}, I_{D} = 0 \text{ V}$ $V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{DS} = 0 \text{ V}, V_{GS} = 0 \text{ V}$	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C	40	15		V
Drain-to-Source Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current  Gate-to-Source Leakage Current  ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS	V <sub>(BR)DSS</sub> /T <sub>J</sub> I <sub>DSS</sub> I <sub>GSS</sub> V <sub>GS(TH)</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C	40	15		
Temperature Coefficient  Zero Gate Voltage Drain Current  Gate-to-Source Leakage Current  ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS	I <sub>DSS</sub>		T <sub>J</sub> = 125°C		15		1400
Gate-to-Source Leakage Current  ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS	I <sub>GSS</sub>		T <sub>J</sub> = 125°C			İ	mV/°C
ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS	V <sub>GS(TH)</sub>		_		1	10	μΑ
ON CHARACTERISTICS (Note 4)  Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS	V <sub>GS(TH)</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$				250	1
Gate Threshold Voltage  Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS			<sub>S</sub> = 20 V			100	nA
Negative Threshold Temperature Coefficient  Drain-to-Source On Resistance  Forward Transconductance  CHARGES, CAPACITANCES AND GATE RESIS							
Drain-to-Source On Resistance Forward Transconductance CHARGES, CAPACITANCES AND GATE RESIS		$V_{GS} = V_{DS}, I_D$	= 70 μΑ	2.0		4.0	V
Forward Transconductance CHARGES, CAPACITANCES AND GATE RESIS	$V_{GS(TH)}/T_J$				6.9		mV/°C
CHARGES, CAPACITANCES AND GATE RESIS	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 40 A		3.6	4.2	mΩ
·	9FS	$V_{DS} = 3 \text{ V}, I_{D}$	= 40 A		80		S
Input Capacitance	STANCES						
	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, } f = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			1900		pF
Output Capacitance	C <sub>oss</sub>				950		-
Reverse Transfer Capacitance	C <sub>rss</sub>				48		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 40 A			32		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				5.7		1
Gate-to-Source Charge	Q <sub>GS</sub>				9.5		1
Gate-to-Drain Charge	$Q_{GD}$				6.6		1
Plateau Voltage	V <sub>GP</sub>				4.8		V
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t <sub>d(on)</sub>				11		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 10 \text{ V}, V_{DS}$	e = 32 V.		47		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 40 \text{ A}, R_G = 2.5 \Omega$			24		1
Fall Time	t <sub>f</sub>				8		1
DRAIN-SOURCE DIODE CHARACTERISTICS					<u> </u>		
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 40 A	T <sub>J</sub> = 25°C		0.9	1.2	V
			T <sub>J</sub> = 125°C		0.8		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 40 A			45		ns
Charge Time	ta				24		1
Discharge Time	+la				21		1
Reverse Recovery Charge	tb	-			41	4	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **TYPICAL CHARACTERISTICS**



# **TYPICAL CHARACTERISTICS**

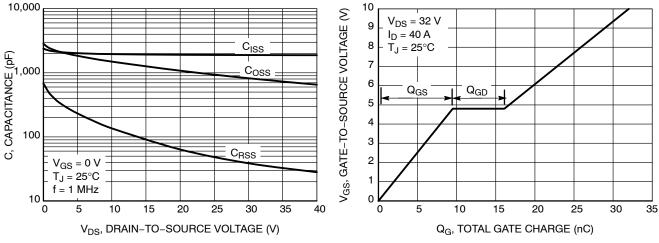


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

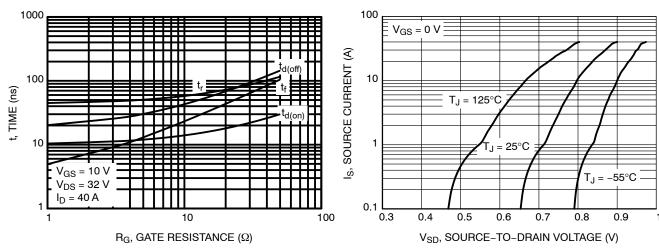


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

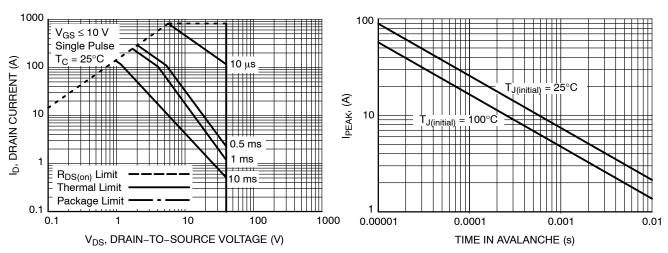


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

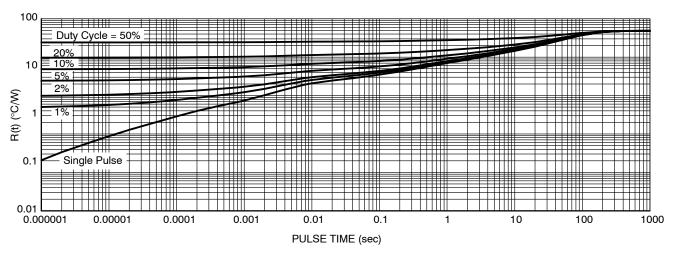


Figure 13. Thermal Response

# **ORDERING INFORMATION**

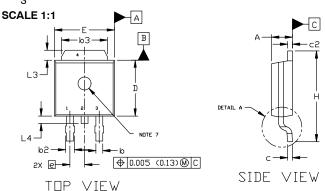
Order Number	Package	Shipping <sup>†</sup>
NVD5C454NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





**DATE 31 MAY 2023** 



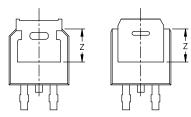


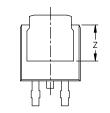
- DIMENSIONING AND TOLERANCING ASME Y14.5M, 1994. CONTROLLING DIMENSION: INCHES
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS 63,
- L3. AND Z. L3, AND Z.

  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR
  GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  DIMENSIONS D AND E ARE DETERMINED AT THE
  OUTERMOST EXTREMES OF THE PLASTIC BODY.
  DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
  DETININAL MOLD ESCALUPE.

- OPTIONAL MOLD FEATURE.

DIM	INCHES		MILLIMETERS		
MIM	MIN.	MAX.	MIN.	MAX.	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
C	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
e	0.090 BSC		2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90 REF		
L2	0.020 BSC		0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

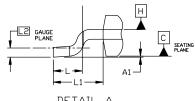




BOTTOM VIEW

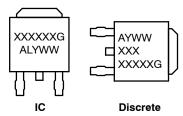
BOTTOM VIEW ALTERNATE CONSTRUCTIONS

5.80 [0.228] 6.20 [0.244] 2.58 3.00 [0.102] [0.118] 1.60 [0.063] 6.17 [0.243]



DETAIL A ROTATED 90° CW

**GENERIC MARKING DIAGRAM\*** 



XXXXXX	= Device Code
Α	= Assembly Location
L	= Wafer Lot
Υ	= Year
WW	= Work Week
G	= Pb-Free Package

\*This information is generic. Please refer to

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DUWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

3 FMITTER

4. COLLECTOR

s

3 GATE

RECOMMENDED MOUNTING FOOTPRINT\*

STYLE 1: STYLE 2: PIN 1. BASE PIN 1. GATE 2. COLLECTOR 2. DRAIL 3. EMITTER 3. SOUF 4. COLLECTOR 4. DRAIL	N 2. CATHODE RCE 3. ANODE	3. GATE	STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE
--	------------------------------	---------	---

STYLE 7: PIN 1. GATE 2. COLLECTOR STYLE 6: STYLE 8: STYLE 9: STYLE 10: PIN 1. MT1 2. MT2 PIN 1. N/C 2. CATHODE 3. ANODE PIN 1. ANODE 2. CATHODE

4. CATHODE

device data sheet for actual part marking. PIN 1. CATHODE 2. ANODE 3. CATHODE Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may 3 RESISTOR ADJUST not follow the Generic Marking. 4. ANODE

DOCUMENT NUMBER:	98AON10527D	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED of the control of	
DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1

4. CATHODE

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales